

Transaction Information

Tool ID	V13V
Tool Status	Connected
Location	Burlington, USA
Wafer Size	200 mm
Fab Section	Metrology
Tool Available Date	2024-01-11

General Product Information

Vendor Supplier	KLA-Tencor
Model	AIT II
Vintage	2009
Serial No	9262
Asset Description	AIT II w/ ADC. Defect Inspection Tool for Semiconductors
Software Version	5.3.17
CIM	SECS, GEM
Process	Defect Inspection

Hardware Configuration (Fab)

Hardware Configuration (Subfab / Auxilliary Units)

Description	Quantity	Status
NONE		

Missing/Faulty Parts / Accesories List

Description	Quantity
NONE	

Tool Pictures

General

EFM, Workstation, Tool Rear



General

EFM, Workstation, Tool Rear



General

EFM, Workstation, Tool Rear



Manufacture Serial

Serial Number Plate

KLA-Tencor™ Corporation
One Technology Drive
Milpitas, California 95035
Manufactured

FEBRUARY 2009

This product conforms to
the applicable requirements
of 21 CFR Subchapter J.

KLA Tencor™

ONE TECHNOLOGY DRIVE
MILPITAS, CALIFORNIA 95035

MODEL No A I T II

PART No 3 8 1 4 4 6

SERIAL No 9 2 6 2

CE

Additional Tool Data Files